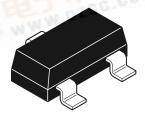


ZXMN6A07F 60V SOT23 N-channel enhancement mode mosfet

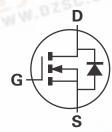
Summary

$V_{(BR)DSS}$ $R_{DS(on)}(\Omega)$		I _D (A)
60	0.250 @ V _{GS} = 10V	1.4
	0.350 @ V _{GS} = 4.5V	1.2



Description

This new generation trench MOSFET from Zetex utilizes a unique structure combining the benefits of low on-state resistance with fast switching speed.



Top view

D

Features

- Low on-resistance
- · Fast switching speed
- · Low threshold
- SOT23 package

Applications

- DC-DC converters
- Power management functions
- Relay and solenoid driving
- Motor control

Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel	
ZXMN6A07FTA	E 7	8	3,000	

Device marking

7N6



Absolute maximum ratings

Parameter		Symbol	Limit	Unit
Drain-source voltage		V_{DSS}	60	V
Gate-source voltage		V_{GS}	± 20	V
Continuous drain current @ V _{GS} = 10V; T _{amb} =	25°C ^(b)	I _D	1.4	А
@ V _{GS} = 10V; T _{amb} =	70°C ^(b)		1.1	
@ V _{GS} = 10V; T _{amb} =	25°C ^(a)		1.2	
Pulsed drain current ^(c)		I _{DM}	6.9	А
Continuous source current (body diode)(b)		I _S	1	Α
Pulsed source current (body diode)(c)		I_{SM}	6.9	Α
Power dissipation at T _{amb} =25°C ^(a)		P_{D}	625	mW
Linear derating factor			5	mW/°C
Power dissipation at T _{amb} =25°C ^(b)		P_{D}	806	mW
Linear derating factor			6.4	mW/°C
Operating and storage temperature range		T _j , T _{stg}	-55 to +150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient	$R_{\Theta JA}$	200	°C/W
Junction to ambient	$R_{\Theta JA}$	155	°C/W

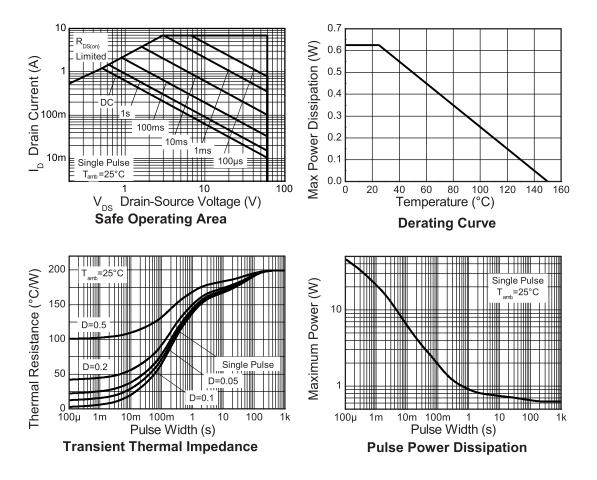
NOTES:

⁽a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

⁽b) For a device surface mounted on FR4 PCB measured at t \leq 5 sec.

⁽c) Repetitive rating - 25mm x 25mm FR4 PCB, D=0.02, pulse width $300\mu s$ - pulse width limited by maximum junction temperature.

Thermal characteristics



Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Static							
Drain-source breakdown voltage	V _{(BR)DSS}	60			V	I _D = 250μA, V _{GS} =0V	
Zero gate voltage drain current	I _{DSS}			1	μΑ	V _{DS} = 60V, V _{GS} =0V	
Gate-body leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V	
Gate-source threshold voltage	$V_{GS(th)}$	1.0		3.0	V	I_D = 250 μ A, V_{DS} = V_{GS}	
Static drain-source on-state resistance (*)	R _{DS(on)}			0.250 0.350	Ω	V _{GS} = 10V, I _D = 1.8A V _{GS} = 4.5V, I _D = 1.3A	
Forward transconductance(*)(‡)	g _{fs}		2.3		S	V _{DS} = 15V, I _D = 1.8A	
Dynamic ^(‡)	•	•	•				
Input capacitance	C _{iss}		166		pF	V _{DS} = 40V, V _{GS} =0V	
Output capacitance	C _{oss}		19.5		pF	f=1MHz	
Reverse transfer capacitance	C _{rss}		8.7		pF		
Switching (†) (‡)							
Turn-on-delay time	t _{d(on)}		1.8		ns	V _{DD} = 30V, V _{GS} = 10V	
Rise time	t _r		1.4		ns	I _D = 1.8A	
Turn-off delay time	t _{d(off)}		4.9		ns	$R_{G} \approx 6.0\Omega$	
Fall time	t _f		2.0		ns		
Total gate charge	Q_g		1.65			V _{DS} = 30V, V _{GS} = 5V I _D = 1.8A	
Total gate charge	Q_g		3.2		nC	V _{DS} = 30V, V _{GS} = 10V	
Gate-source charge	Q _{gs}		0.67		nC	I _D = 1.8A	
Gate drain charge	Q _{gd}		0.82		nC		
Source-drain diode							
Diode forward voltage ^(*)	V_{SD}		0.80	0.95	>	T_{j} =25°C, I_{S} = 0.45A, V_{GS} =0V	
Reverse recovery time ^(‡)	t _{rr}		20.5		ns	T _j =25°C, I _F = 1.8A,	
Reverse recovery charge ^(‡)	Q _{rr}		21.3		nC	di/dt=100A/μs	

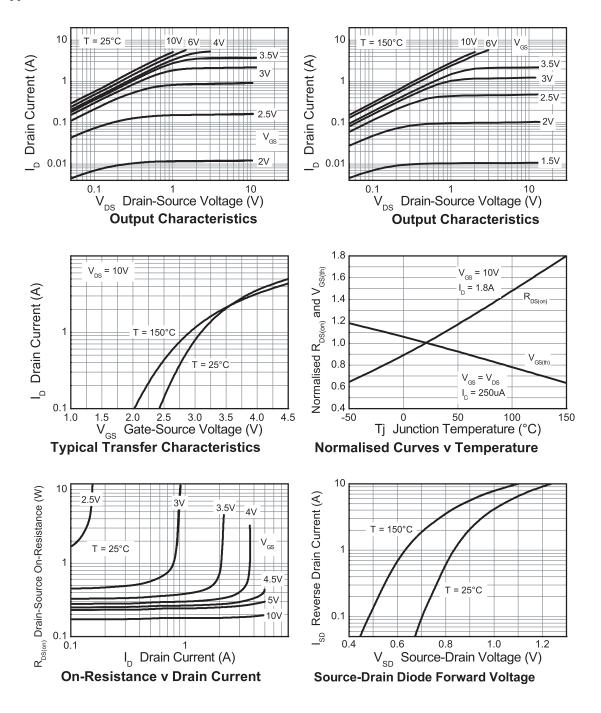
NOTES:

^(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

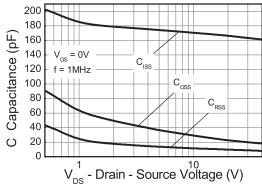
^(†) Switching characteristics are independent of operating junction temperature.

^(‡) For design aid only, not subject to production testing.

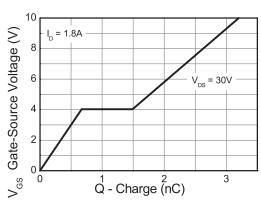
Typical characteristics



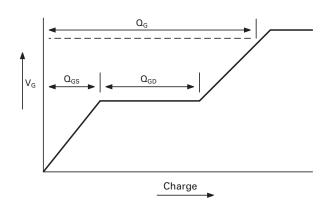
Typical characteristics



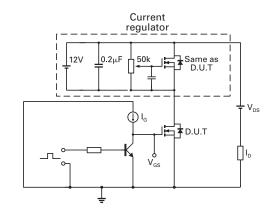
Capacitance v Drain-Source Voltage



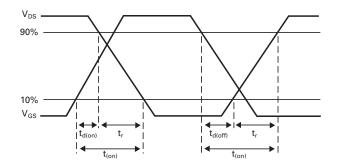
Gate-Source Voltage v Gate Charge



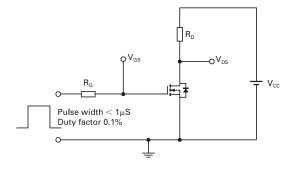
Basic gate charge waveform



Gate charge test circuit

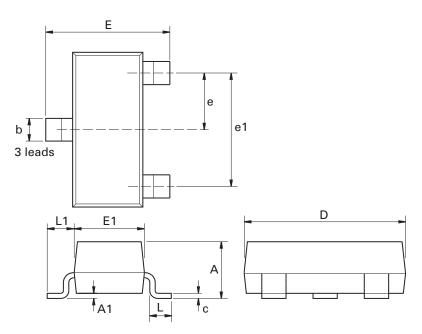


Switching time waveforms



Switching time test circuit

Package outline - SOT23



Dim.	Millin	neters	Inc	hes	Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Max.	Max.
Α	-	1.12	-	0.044	e1	1.90 NOM		0.075 NOM	
A1	0.01	0.10	0.0004	0.004	Е	2.10	2.64	0.083	0.104
b	0.30	0.50	0.012	0.020	E1	1.20	1.40	0.047	0.055
С	0.085	0.120	0.003	0.008	L	0.25	0.62	0.018	0.024
D	2.80	3.04	0.110	0.120	L1	0.45	0.62	0.018	0.024
е	0.95	NOM	0.0375 NOM		-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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